BLL8H1214L-250; BLL8H1214LS-250

LDMOS L-band radar power transistor

Rev. 2 — 13 January 2015

Product data sheet

1. Product profile

1.1 General description

250 W LDMOS power transistor intended for L-band radar applications in the 1.2 GHz to 1.4 GHz range.

Table 1. Test information

Typical RF performance at $T_{case} = 25$ °C; $t_p = 300 \ \mu s$; $\delta = 10$ %; $I_{Dq} = 100 \ mA$; in a class-AB production test circuit.

Test signal	f	V _{DS}	PL	Gp	ηם	t _r	t _f
	(GHz)	(V)	(W)	(dB)	(%)	(ns)	(ns)
pulsed RF	1.2 to 1.4	50	250	17	55	15	5

1.2 Features and benefits

- Easy power control
- Integrated dual side ESD protection
- High flexibility with respect to pulse formats
- Excellent ruggedness
- High efficiency
- Excellent thermal stability
- Designed for broadband operation (1.2 GHz to 1.4 GHz)
- Internally matched for ease of use
- Compliant to Directive 2002/95/EC, regarding restriction of hazardous substances (RoHS)

1.3 Applications

 L-band power amplifiers for radar applications in the 1.2 GHz to 1.4 GHz frequency range



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2. Pinning information

Table 2.	Pinning		
Pin	Description	Simplified outline	Graphic symbol
BLL8H12	14L-250 (SOT502A)		
1	drain		_
2	gate		
3	source		
			3
			sym112
BLL8H12	14LS-250 (SOT502B)		
1	drain		
2	gate		، لــــا
3	source		
			sym112

[1] Connected to flange.

3. Ordering information

Table 3.Ordering information

Type number	Packag	lackage					
	Name	Description	Version				
BLL8H1214L-250	-	flanged ceramic package; 2 mounting holes; 2 leads	SOT502A				
BLL8H1214LS-250	-	earless flanged ceramic package; 2 leads	SOT502B				

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{DS}	drain-source voltage			-	100	V
V _{GS}	gate-source voltage			-6	+13	V
T _{stg}	storage temperature			-65	+150	°C
Tj	junction temperature		<u>[1]</u>	-	225	°C

[1] Continuous use at maximum temperature will affect the reliability, for details refer to the on-line MTF calculator.

5. Thermal characteristics

Table 5.	Table 5. Thermal characteristics						
Symbol	Parameter	Conditions	Тур	Unit			
Z _{th(j-c)}	transient thermal impedance from	$T_{case} = 85 \ ^{\circ}C; P_{L} = 250 \ W$					
	junction to case	$t_p = 100 \ \mu s; \ \delta = 10 \ \%$	0.10	K/W			
		$t_p = 200 \ \mu s; \ \delta = 10 \ \%$	0.13	K/W			
		$t_p = 300 \ \mu s; \ \delta = 10 \ \%$	0.15	K/W			
		$t_p = 100 \ \mu s; \ \delta = 20 \ \%$	0.14	K/W			
		$t_p = 500 \ \mu s; \ \delta = 20 \ \%$	0.20	K/W			

6. Characteristics

Table 6.	DC characteristics
T 05 00	

$T_j = 25 \ ^{\circ}C.$						
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{(BR)DSS}	drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; \text{ I}_{D} = 2.7 \text{ mA}$	100	-	-	V
V _{GS(th)}	gate-source threshold voltage	$V_{DS} = 10 \text{ V}; \text{ I}_{D} = 270 \text{ mA}$	1.3	1.8	2.25	V
I _{DSS}	drain leakage current	$V_{GS} = 0 V; V_{DS} = 50 V$	-	-	1.4	μA
I _{DSX}	drain cut-off current	$\label{eq:VGS} \begin{array}{l} V_{GS} = V_{GS(th)} + 3.75 \; V; \\ V_{DS} = 10 \; V \end{array}$	32	42	-	A
I _{GSS}	gate leakage current	V_{GS} = 11 V; V_{DS} = 0 V	-	-	140	nA
9 _{fs}	forward transconductance	V_{DS} = 10 V; I_{D} = 270 mA	1.6	2.3	-	S
R _{DS(on)}	drain-source on-state resistance	$\label{eq:VGS} \begin{array}{l} V_{GS} = V_{GS(th)} + 3.75 \; V; \\ I_{D} = 9.5 \; A \end{array}$	-	100	169	mΩ

Table 7. RF characteristics

Test signal: pulsed RF; $t_p = 300 \ \mu s$; $\delta = 10 \ \%$; RF performance at $V_{DS} = 50 \ V$; $I_{Dq} = 100 \ mA$; $T_{case} = 25 \ ^{\circ}C$; unless otherwise specified, in a class-AB production test circuit.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{DS}	drain-source voltage	$P_{L} = 250 \text{ W}$	-	-	50	V
G _p	power gain	$P_{L} = 250 W$	15	17	-	dB
RL _{in}	input return loss	$P_{L} = 250 W$	-	-10	-	dB
P _{L(1dB)}	output power at 1 dB gain compression		-	300	-	W
η _D	drain efficiency	$P_{L} = 250 W$	49	55	-	%
Pdroop(pulse)	pulse droop power	$P_{L} = 250 W$	-	0	0.3	dB
t _r	rise time	$P_{L} = 250 W$	-	15	-	ns
t _f	fall time	$P_{L} = 250 W$	-	5	-	ns

7. Application information

7.1 Ruggedness in class-AB operation

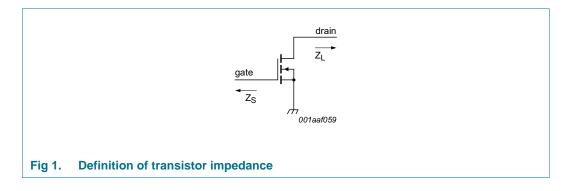
The BLL8H1214L-250 and BLL8H1214LS-250 are capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions: V_{DS} = 50 V; I_{Dg} = 100 mA; P_L = 250 W; t_p = 300 μ s; δ = 10 %.

7.2 Impedance information

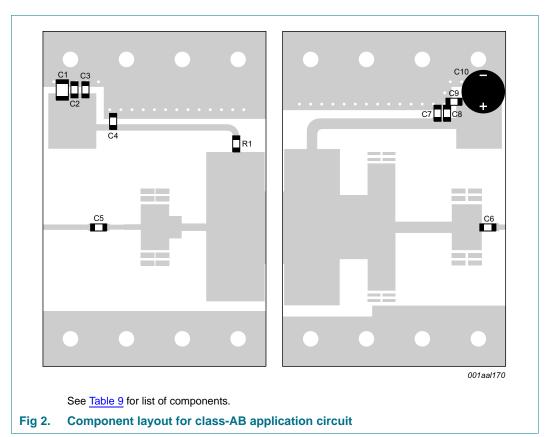
Table 8.Typical impedance

Typical values unless otherwise specified.

f	Z _S	ZL
(GHz)	(Ω)	(Ω)
1.2	1.268 – j2.623	2.987 – j1.664
1.3	2.193 – j2.457	2.162 – j1.326
1.4	2.359 – j2.052	1.604 – j1.887



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7.3 Application circuit

Table 9.List of components

See Figure 2.

Striplines are on a Rogers Duroid 6006 Printed-Circuit Board (PCB); $\varepsilon_r = 6.15$ F/m; thickness = 0.64 mm

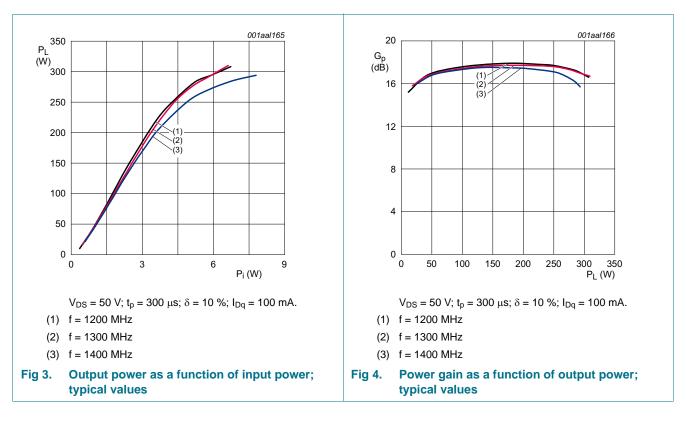
Component	Description	Value	Remarks
C1	multilayer ceramic chip capacitor	10 μF, 35 V [1]	
C2, C4	multilayer ceramic chip capacitor	51 pF [2]	
C3, C8	multilayer ceramic chip capacitor	1 nF [2]	
C5	multilayer ceramic chip capacitor	82 pF [3]	
C6, C7	multilayer ceramic chip capacitor	56 pF [3]	
C9	multilayer ceramic chip capacitor	100 pF [3]	
C10	electrolytic capacitor	47 μF, 63 V	
R1	SMD resistor	10 Ω	SMD 0603

[1] American Technical Ceramics type 100A or capacitor of same quality.

[2] American Technical Ceramics type 100B or capacitor of same quality.

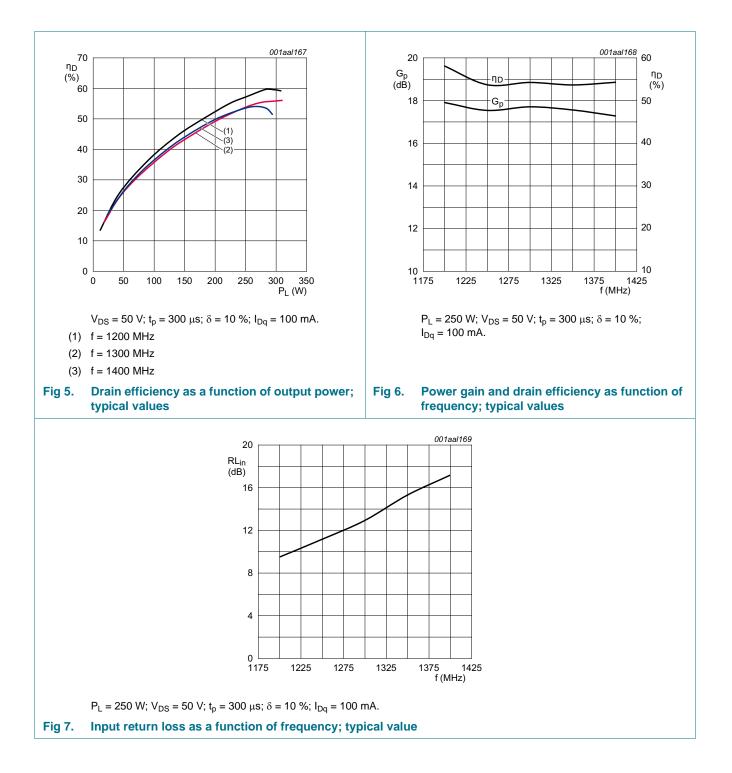
[3] American Technical Ceramics type 800B or capacitor of same quality.

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7.4 RF performance graphs

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8. Package outline

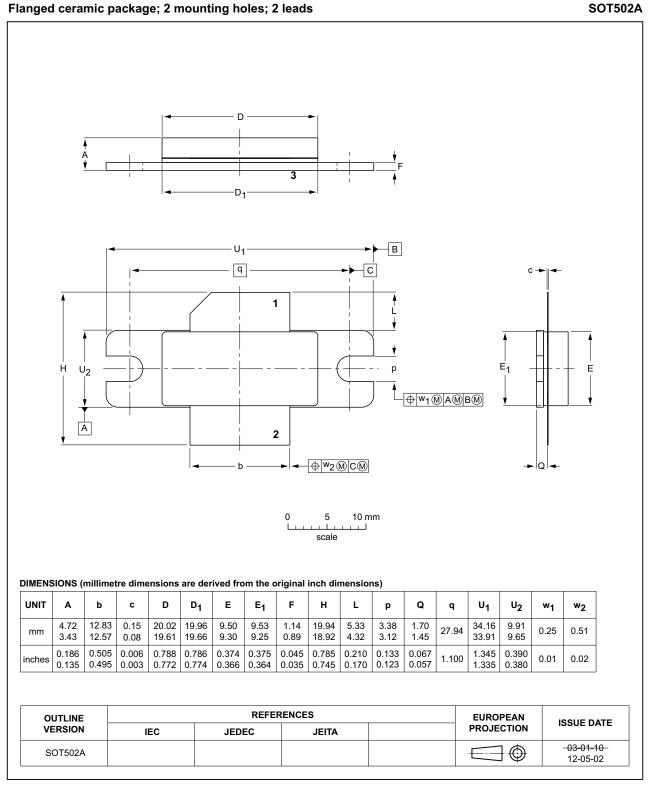


Fig 8. Package outline SOT502A

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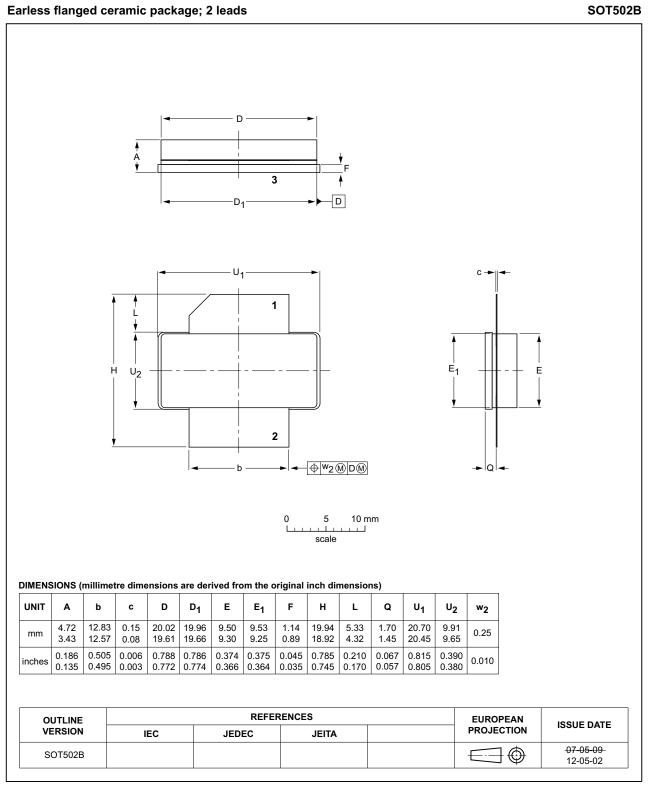


Fig 9. Package outline SOT502B

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9. Handling information

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

10. Abbreviations

Table 10. Abl	Table 10. Abbreviations				
Acronym	Description				
ESD	ElectroStatic Discharge				
L-band	Long wave Band				
LDMOS	Laterally Diffused Metal-Oxide Semiconductor				
MTF	Median Time to Failure				
SMD	Surface Mounted Device				
VSWR	Voltage Standing-Wave Ratio				

11. Revision history

Table 11.Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BLL8H1214L-250_1214LS-250 v.2	20150113	Product data sheet	-	BLL8H1214L-250_1214LS-250 v.1
Modifications:	• Table 7 on	Table 7 on page 3: rows ' t_p ' and ' δ ' have been removed.		
BLL8H1214L-250_1214LS-250 v.1	20140930	Objective data sheet	-	-

12. Legal information

12.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

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[2] The term 'short data sheet' is explained in section "Definitions".

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